



Thin Film Chip Fuse

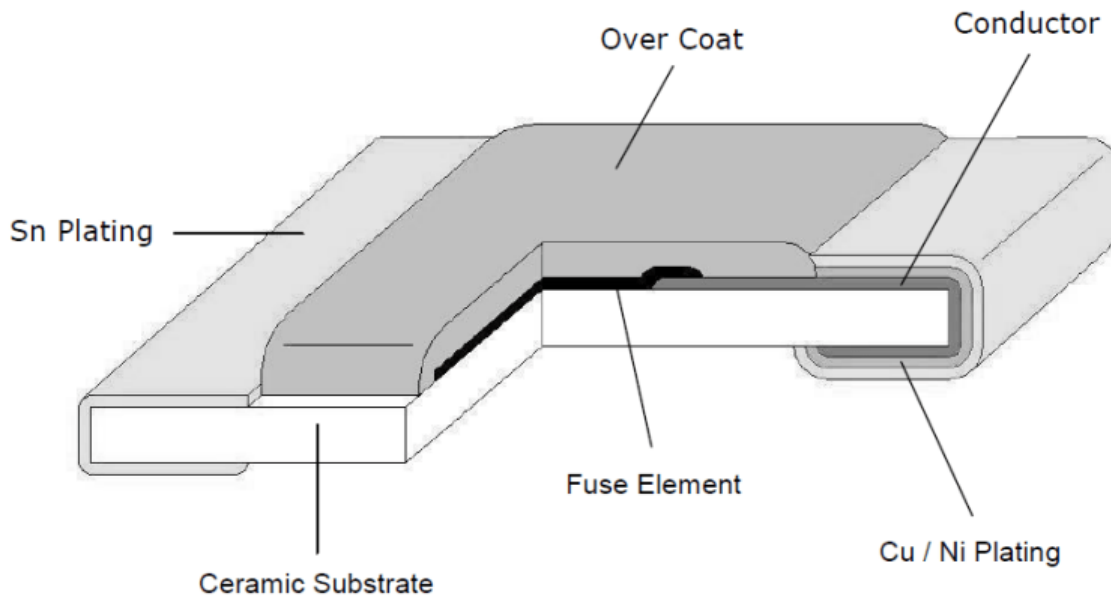
(AEC-Q200 tested/ )

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1. Scope

This specification applies for the fuse series of thin film chip fuse made by TA-I.

2. Construction



3. Type Designation

CFS	06	V5	T	R50
	Size	Rate Voltage	Packaging	Rate Current
Chip Fuse	04:0402(1005) 06:0603(1608) 12:1206(3216)	V6:63V V5:50V V3:32V	T: Paper Tape (5K/10K)	R50:0.5A 1R0:1A

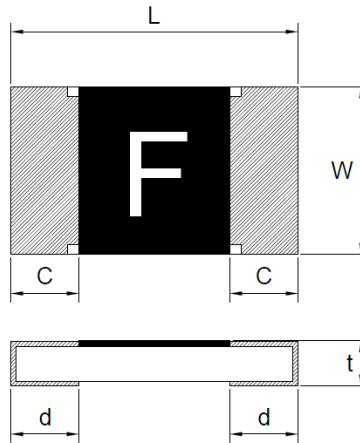


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4. Dimensions



Unit: mm

Type (Inch Size code)	Dimensions (mm)				
	L	W	C	d	t
CFS04 (0402)	1.0±0.1	0.52±0.05	0.2±0.1	0.25±0.1	0.35±0.05
CFS06 (0603)	1.6±0.1	0.80±0.10	0.3±0.2	0.35±0.2	0.45±0.10
CFS12 (1206)	3.1±0.1	1.55±0.10	0.5±0.3	0.50±0.2	0.60±0.10

5. Applications and ratings

Part Designation	Marking	Rated Current	Fusing Time	Resistance (mΩ) Tolerance±25%	Rated Voltage	Breaking Capacity	Body Temperature rising
CFS04V3TR50	F	0.50A	Open within 5sec.at250% rated current	300	DC 32V	DC32V 35A	<75°C at 100% rated current
CFS04V3TR80	K	0.80A		78			
CFS04V3T1R0	L	1.00A		75			
CFS04V3T1R25	M	1.25A		44			
CFS04V3T1R50	P	1.50A		34.5			
CFS04V3T1R60	N	1.60A		29.5			
CFS04V3T2R0	S	2.00A		23			
CFS04V3T2R50	T	2.50A		18			
CFS04V3T3R0	3	3.00A		15			
CFS04V3T3R15	U	3.15A		14			
CFS04V3T4R0	W	4.00A	10				

*Resistance value was measured with less than 10% of rated current



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Part Designation	Marking	Rated Current	Fusing Time	Resistance (mΩ) Tolerance±25%	Rated Voltage	Breaking Capacity	Body Temperature rising
CFS06V5TR40	<u>E</u>	0.4A	Open within 5sec.at250% rated current	350	DC 50V	50A DC50V/ AC35V	<75°C at 100% rated current
CFS06V5TR50	F	0.50A		232			
CFS06V3TR63	I	0.63A		150	DC 32V	50A DC32V/ AC35V	
CFS06V3TR70	J	0.70A		148			
CFS06V3TR80	K	0.80A		113			
CFS06V3T1R0	L	1.00A		67			
CFS06V3T1R25	<u>M</u>	1.25A		50			
CFS06V3T1R50	P	1.50A		42			
CFS06V3T1R60	N	1.60A		40			
CFS06V3T2R0	S	2.00A		27			
CFS06V3T2R50	T	2.50A		19.5			
CFS06V3T3R00	3	3.00A		16			
CFS06V3T3R15	U	3.15A		15			
CFS06V3T4R0	W	4.00A		11			
CFS06V3T5R0	Y	5.00A		8			
CFS06V3T6R0	<u>6</u>	6.00A		6			

*Resistance value was measured with less than 10% of rated current

Part Designation	Marking	Rated Current	Fusing Time	Resistance (mΩ) Tolerance±25%	Rated Voltage	Breaking Capacity	Body Temperature rising
CFS12V6TR50	F	0.50A	Open within 5sec.at250% rated current	596	DC 63V	DC63V 50A	<75°C at 100% rated current
CFS12V6TR80	K	0.80A		165			
CFS12V6T1R0	L	1.00A		132			
CFS12V6T1R25	<u>M</u>	1.25A		90			
CFS12V6T1R50	P	1.50A		79			
CFS12V6T2R0	S	2.00A		41	DC 32V	DC32V 50A	
CFS12V3T2R50	T	2.50A		33			
CFS12V3T3R00	3	3.00A		23			
CFS12V3T4R0	W	4.00A		15.5			
CFS12V3T5R0	Y	5.00A		13			
CFS12V3T7R0	Z	7.00A		7			

*Resistance value was measured with less than 10% of rated current



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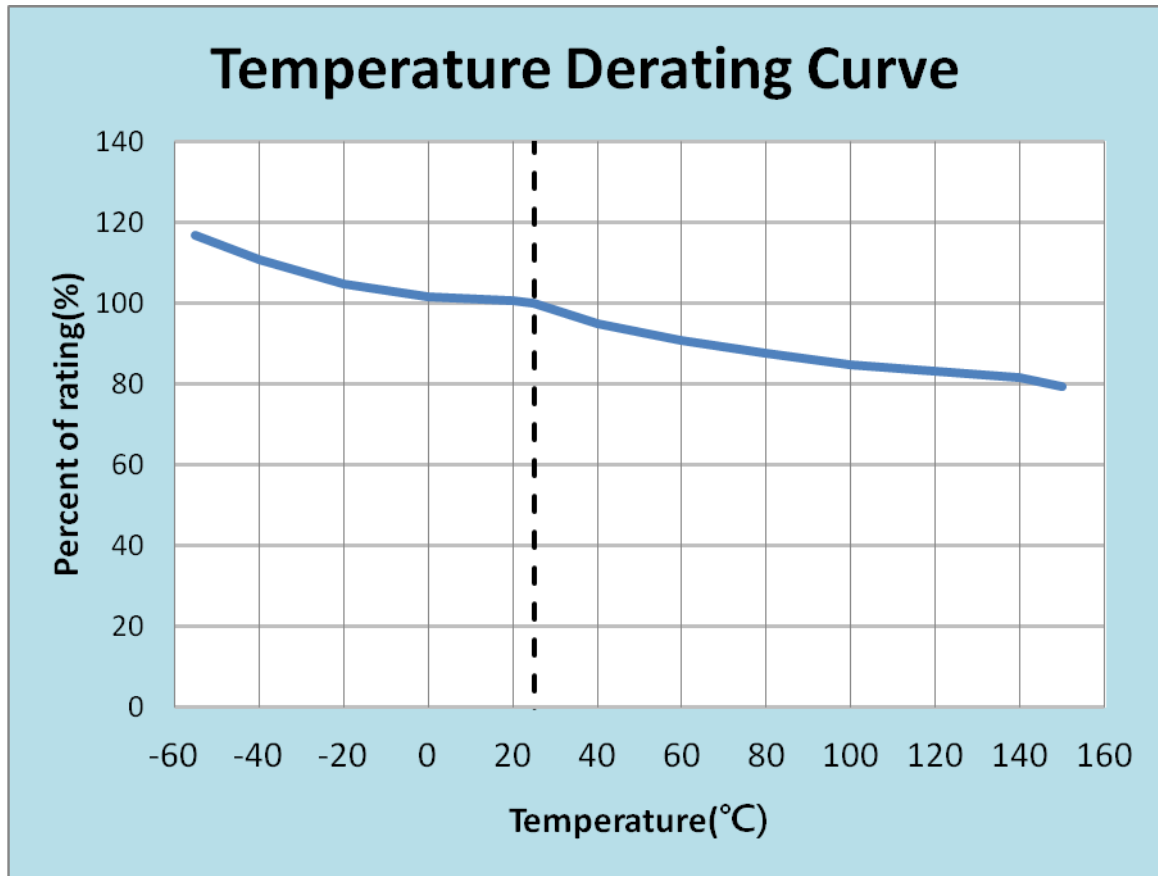
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6 Temperature Derating Curve

6.1 Normal Ambient Temperature: 25°C

6.2 Operating Temperature: -55°C ~150°C , with proper derating factor as below:





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7 Reliability Tests

No.	Parameter	Test Method	Requirement
#1	Solderability	aging 4 hours at 150 °C dry heat Lead-free solder bath at 245±3 °C for 3±0.5 seconds. 260±3 °C for 7±0.5 seconds	95% coverage minimum
#2	Resistance to solder Heat	Immerse the specimens in and eutectic solder at 260+5/-0°C for 10±1S .	±10%
#3	Moisture Resistance	T=24 hours / Cycle ,10Cycles . Notes: Steps 7a& 7b not required. Unpowered .	±10%
#4	Thermal Shock	Temperature -55°C/+155°C. Number of cycles required:300 Maximum transfer time-20 seconds, Dwell time-15 minutes. Air-Air.	±10%
#5	Mechanical Shock	Wave Form: Tolerance for half sine shock pulse. Peak value is 100g's. Normal duration(D) is 6(ms)	±10%
#6	Vibration	5 g's for 20 min., 12 cycles each of 3 orientations. (Note: Test from 10-2000 Hz.)	±10%
#7	Terminal Strength	Force of 1.8kg for 1206/0603 Force of 1.0kg for 0402	±10%
#8	High Temperature Storage	with exemptions 1000 hrs. @ T=125°C. Unpowered. Measurement at 24±2 hours after test conclusion.	±10%
#9	Temperature Cycling	1000 Cycles (-40°C to +125°C) 30min maximum dwell time at each temperature extreme. 1 min. Maximum transition time. Measurement at 24±4 hours after test conclusion.	±10%
#10	Bias Humidity	1000 hours 85°C/85%RH. Note: Specified conditions: 10% of operating current. Measurement at 24±2 hours after test conclusion.	±10%
#11	Operational Life	1000 hours TA=85°C at 70% rated current. Measurement at 24±2 hours after test conclusion	±10%
#12	Resistance to Solvent	a:Isopropyl Alcohol : Mineral Spirits= 1 : 3 b:Terpene Defluxer (Bioact EC-7R) c:Deionized water : Propylene Glycol : Monomethyl Ether : monoethanolamine = 42 : 1 : 1	No evident damages on protective coating
#13	Board Flex(Bending)	3mm deflection	±10%
#14	Carrying capacity	Rated current ,4hr	±10%
#15	Fusing Time	250% of its rated current	< 5 sec
#16	Interrupting Ability	After the fuse is interrupted ,rated voltage applied for 30sec again	No mechanical damages
#17	Temperature Rise	100% of its rated current, Measure of surface temperature	Δ T<75°C
#18	Residual Resistance	Measure DC resistance after fusing	10kΩ and more
#19	Low Temperature Storage	1000 hrs. @ T=-55°C. Unpowered. Measurement at 24±2 hours after test conclusion.	±10%



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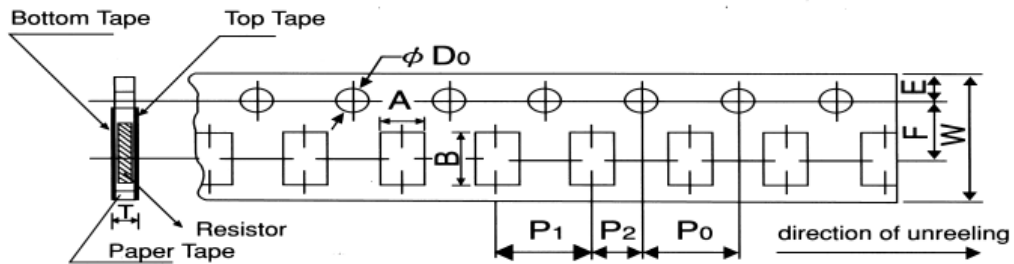
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8 Taping & Reel

8.1 Taping Dimensions

4mm pitch paper



Packing	Type	A	B	W	F	E	P ₁	P ₂	P ₀	D ₀	T
Paper Tape	CFS04	0.7±0.05	1.2±0.05	8.0±0.2	3.5±0.05	1.75±0.1	2.0±0.1	2.0±0.05	4.0±0.1	$\phi \begin{matrix} +0.1 \\ 1.5 \\ 0 \end{matrix}$	0.45±0.1
Paper Tape	CFS06	1.1±0.1	1.9±0.1	8.0±0.2	3.5±0.05	1.75±0.1	4.0±0.1	2.0±0.05	4.0±0.1	$\phi \begin{matrix} +0.1 \\ 1.5 \\ -0 \end{matrix}$	0.64±0.1
Paper Tape	CFS12	2.0±0.15	3.6±0.2	8.0±0.2	3.5±0.05	1.75±0.1	4.0±0.1	2.0±0.05	4.0±0.1	$\phi \begin{matrix} +0.1 \\ 1.5 \\ -0 \end{matrix}$	0.84±0.1

Unit: mm

		Paper Tape	
		2 mm pitch	
		180mm/R	
CFS	04	10000	

		Paper Tape	
		4 mm pitch	
		180mm/R	
CFS	06	5000	
CFS	12	5000	

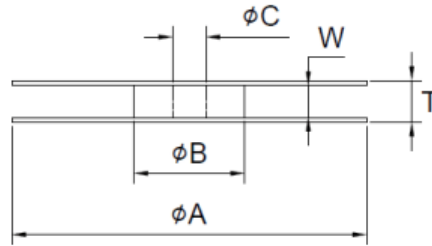


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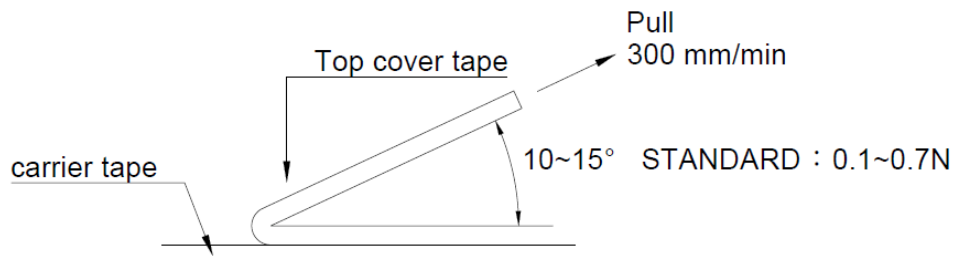
8.2 Reel Specifications



Unit: mm

Series	ϕA	ϕB	ϕC	W	T
CFS04 CFS06 CFS12	178 ± 2.0	60.0 ± 1.0	13.0 ± 1.0	9.0 ± 1.0	11.4 ± 2.0

8.3 Peel –off force:



9 Storage Conditions:

Temperature: 5°C~35°C, Humidity: 40%~75%

10 Shelf Life:

2 years from manufacturing date



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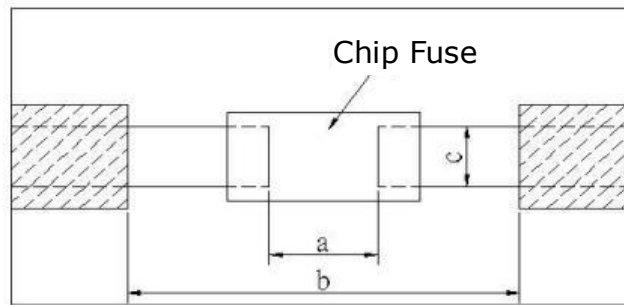
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11 Label



12 Recommended land patterns



Land pattern		Dimension		
Type	Size	a	b	c
CFS	04 (0402)	0.55~0.65	1.40~1.60	0.74~0.94
CFS	06 (0603)	0.85~0.95	2.00~2.20	1.50~1.70
CFS	12 (1206)	0.95~1.05	4.40~5.00	2.30~2.50

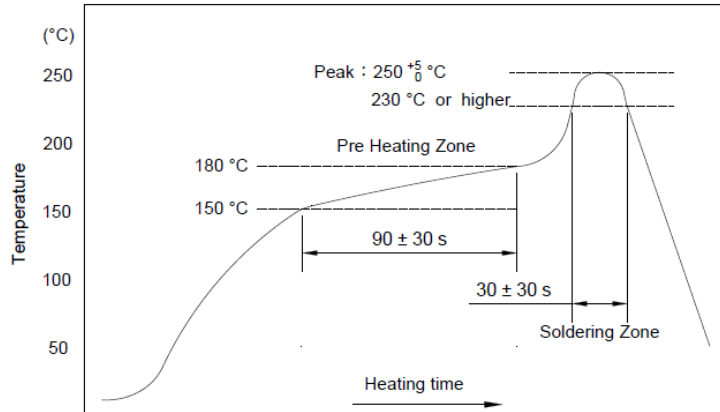


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13. Recommend IR – Reflow profile: (solder: Sn96.5 / Ag3 / Cu0.5)



Peak : $250 \pm 5/0^{\circ}\text{C}$, 5 sec.
Pre-heat Zone : 150 to 180 °C , 90±30 sec
Soldering Zone : 230°C or higher , 30±10 sec

14. Approval by UL248-14

The fuses have been approved by UL.
File No. of UL Recognition is E241710

15. ECN

Engineering Change Notice: The customer will be informed with ECN if there is significant modification on the characteristics and materials described in Approval Sheet.

16. Manufacturing Country & City:

TA-I TECHNOLOGY CO., LTD. (Taiwan– Tao Yuan)

Tel: (+886) 3-3246169 Fax: (+886) 3-3246167

Associated companies:

(1) TA-I TECHNOLOGY (SU ZHOU) CO., LTD. (China – Su Zhou)

Tel: (+86) 512-63457879 Fax: (+86) 512-63457869

(2) TA-I TECHNOLOGY ELECTRONIC (DONGGUAN) CO., LTD. (China –Dongguan)

Tel: (+86) 769-8339-4790~3 Fax : (+86) 769-8339-4794

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(5) P.T.TAI ELECTRONIC Indonesia (Indonesia – Jakarta)

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TA-I TECHNOLOGY CO., LTD



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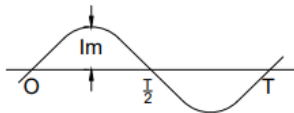
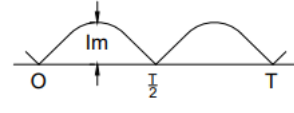
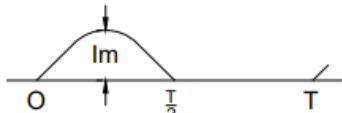
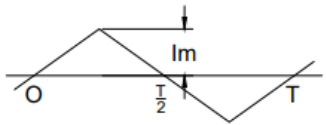
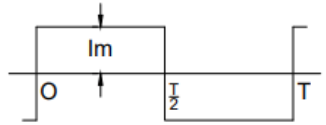
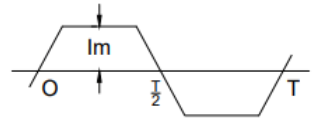
17. Selection Guideline of Fuse:

■ Checklist of selection factors

- ⊙ Normal operating current
- ⊙ Normal operating voltage (AC or DC)
- ⊙ Ambient Temperature
- ⊙ Overload current and length of time in which the fuse must open .
- ⊙ Type of fuse (SMD or Tube) and physical size limitation (0603 or 1206)
- ⊙ Agency Approval required (e.g., UL248-14)

■ Normal operating current

e.g., Rectangular Wave, If $I_p = 1.5 \text{ A}$, Normal operating current = 1.5 A

No.	Type	Waveform	Formula
1	Sinusoidal Waveform		$\frac{1}{\sqrt{2}} I_m \cong 0.707 I_m$
2	All Wave Rectification		$\frac{1}{\sqrt{2}} I_m \cong 0.707 I_m$
3	Half Wave		$0.5 I_m$
4	Triangle Waveform		$\frac{1}{3} I_m \cong 0.577 I_m$
5	Rectangular Waveform		I_m
6	Trapezoidal Waveform		$I_m \sqrt{1 - \frac{8\alpha}{3T}}$



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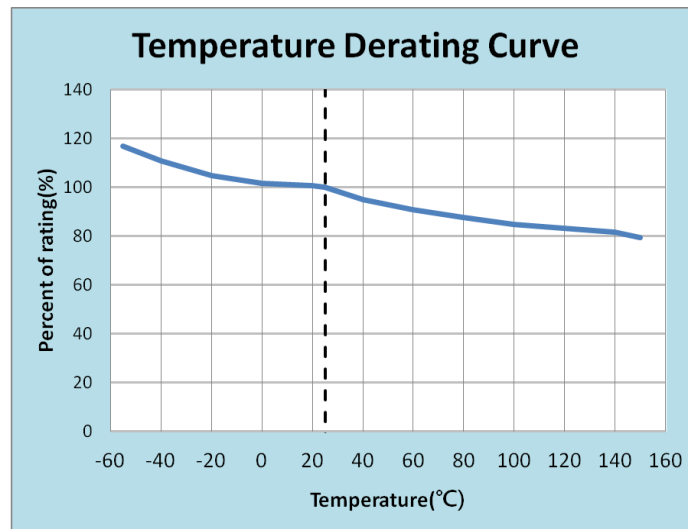
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No.	Type	Waveform	Formula
7	Rectangular Pulse		$I_m \sqrt{\frac{\tau}{T}}$
8	Triangle Pulse		$I_m \sqrt{\frac{\tau}{3T}}$

■ Derating ratio for different ambient Temperature

- ⊙ Referring to bottom figure and select the appropriate derating ratio:
e.g., Ambient temperature is 60 degree C
the derating ratio ≈ 0.95



■ Calculating the required rating of fuse needed.

- ⊙ Safety coefficient: 70% is safety coefficient from practical experience
- ⊙ $\frac{\text{Normal Operating Current}}{0.7 \times \text{derating ratio}} < \text{rating current of fuse}$
- ⊙ e.g.
Condition: Normal operating current = 1.5 A
Ambient temperature 40 °C : Derating ratio ≈ 0.95



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$$\frac{1.5}{0.7 \times 0.95} < \text{rating current of fuse}$$

$$2.255 < \text{rating current of fuse}$$

■ Determination of the type of fuse

e.g.Condition:

- ◆ Calculating value =2.255 A , 2.255A < rating current of fuse
- ◆ Normal operating voltage : DC 12 V
- ◆ Following bottom index-table: suggesting use CFS06V3T2R50.

Part Designation	Marking	Rated Current	Rated Voltage	Part Designation	Marking	Rated Current	Rated Voltage	Part Designation	Marking	Rated Current	Rated Voltage
CFS04V3TR50	F	0.5A	32V	CFS06V5TR40	<u>E</u>	0.40A	50V	CFS12V6TR50	F	0.50A	63V
CFS04V3TR80	K	0.80A	32V	CFS06V5TR50	F	0.5A	50V	CFS12V6TR80	K	0.80A	63V
CFS04V3T1R0	L	1.00A	32V	CFS06V3TR63	I	0.63A	32V	CFS12V6T1R0	L	1.00A	63V
CFS04V3T1R25	<u>M</u>	1.25A	32V	CFS06V3TR70	J	0.7A	32V	CFS12V6T1R25	<u>M</u>	1.25A	63V
CFS04V3T1R50	P	1.50A	32V	CFS06V3TR80	K	0.80A	32V	CFS12V6T1R50	P	1.50A	63V
CFS04V3T1R60	N	1.60A	32V	CFS06V3T1R0	L	1.00A	32V	CFS12V6T2R0	S	2.00A	63V
CFS04V3T2R0	S	2.00A	32V	CFS06V3T1R25	<u>M</u>	1.25A	32V	CFS12V3T2R50	T	2.50A	32V
CFS04V3T2R50	T	2.50A	32V	CFS06V3T1R50	P	1.50A	32V	CFS12V3T3R00	3	3.00A	32V
CFS04V3T3R0	3	3.00A	32V	CFS06V3T1R60	N	1.60A	32V	CFS12V3T4R0	W	4.00A	32V
CFS04V3T3R15	U	3.15A	32V	CFS06V3T2R0	S	2.00A	32V	CFS12V3T5R0	Y	5.00A	32V
CFS04V3T4R0	W	4.00A	32V	CFS06V3T2R50	T	2.50A	32V	CFS12V3T7R0	Z	7.00A	32V
				CFS06V3T3R00	3	3.00A	32V				
				CFS06V3T3R15	U	3.15A	32V				
				CFS06V3T4R0	W	4.00A	32V				
				CFS06V3T5R0	Y	5.00A	32V				
				CFS06V3T6R0	<u>G</u>	6.00A	32V				

■ Inrush current:

- ◆ Considering inrush waveform & calculate I^2t (A²s) value
- ◆ Choosing fuse's I^2t (A²s) value > calculate I^2t (A²s) value
- ◆ Considering Ratio of I^2t repeat numbers to blowing .
- ◆ Confirm with us.

e.g., choosing 0603 Fuse

Condition:



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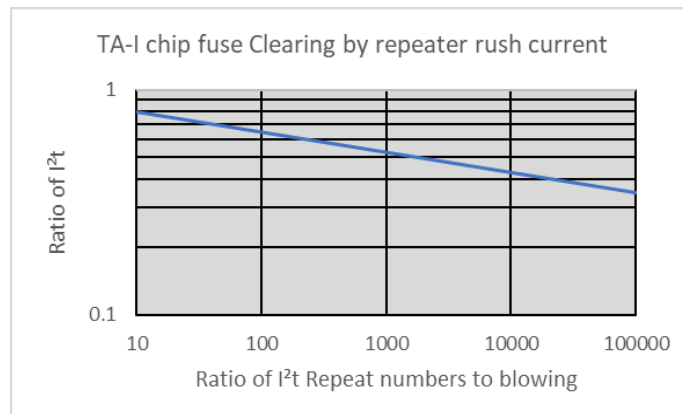
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1. Rectangular Wave, $I_p = 4 \text{ A}$, $t = 1 \text{ ms}$, calculate $I_p^2 t = 4^2 \times 1 \times 10^{-3} = 0.016 \text{ (A}^2\text{s)}$
2. Choosing CFS06V3T1R25, $I^2 t = 0.057 \text{ (A}^2\text{s)}$ → Page 13 index-table
3. Inrush shock : 100,000 times (≈ 0.35) → inrush ratio
4. Choosing fuse's $I^2 t \text{ (A}^2\text{s)}$ value X Derating ratio (inrush 100000 times) > calculate $I^2 t \text{ (A}^2\text{s)}$ value
5. $0.057 \times 0.35 = 0.01995 \text{ (A}^2\text{s)} > 0.016$ → CFS06V3T1R25 is able to meet circuit's application

TA-I FUSE $I^2 t \text{ (A}^2 \text{ s)}$					
Part Number	Typical $I^2 t \text{ (A}^2 \text{ s)}^*$	Part Number	Typical $I^2 t \text{ (A}^2 \text{ s)}^*$	Part Number	Typical $I^2 t \text{ (A}^2 \text{ s)}^*$
CFS04V3TR50	0.00370	CFS06V5TR40	0.004	CFS12V6TR50	0.030
CFS04V3TR80	0.00947	CFS06V5TR50	0.009	CFS12V6TR80	0.068
CFS04V3T1R0	0.01479	CFS06V3TR63	0.017	CFS12V6T1R0	0.098
CFS04V3T1R25	0.02310	CFS06V3TR70	0.023	CFS12V6T1R25	0.155
CFS04V3T1R50	0.02400	CFS06V3TR80	0.024	CFS12V6T1R50	0.236
CFS04V3T1R60	0.03734	CFS06V3T1R0	0.026	CFS12V6T2R0	0.339
CFS04V3T2R0	0.04040	CFS06V3T1R25	0.057	CFS12V3T2R50	0.605
CFS04V3T2R50	0.06760	CFS06V3T1R50	0.081	CFS12V3T3R00	0.933
CFS04V3T3R0	0.09860	CFS06V3T1R60	0.086	CFS12V3T4R0	1.537
CFS04V3T3R15	0.10868	CFS06V3T2R0	0.115	CFS12V3T5R0	2.533
CFS04V3T4R0	0.11450	CFS06V3T2R50	0.200	CFS12V3T7R0	5.684
		CFS06V3T3R00	0.210		
		CFS06V3T3R15	0.279		
		CFS06V3T4R0	0.326		
		CFS06V3T5R0	0.622		
		CFS06V3T6R0	2.700		

Note*: Typical $I^2 t$ value is measured at 10x-rated current, application with surge over 10x-rated current.

Please confirm with us.





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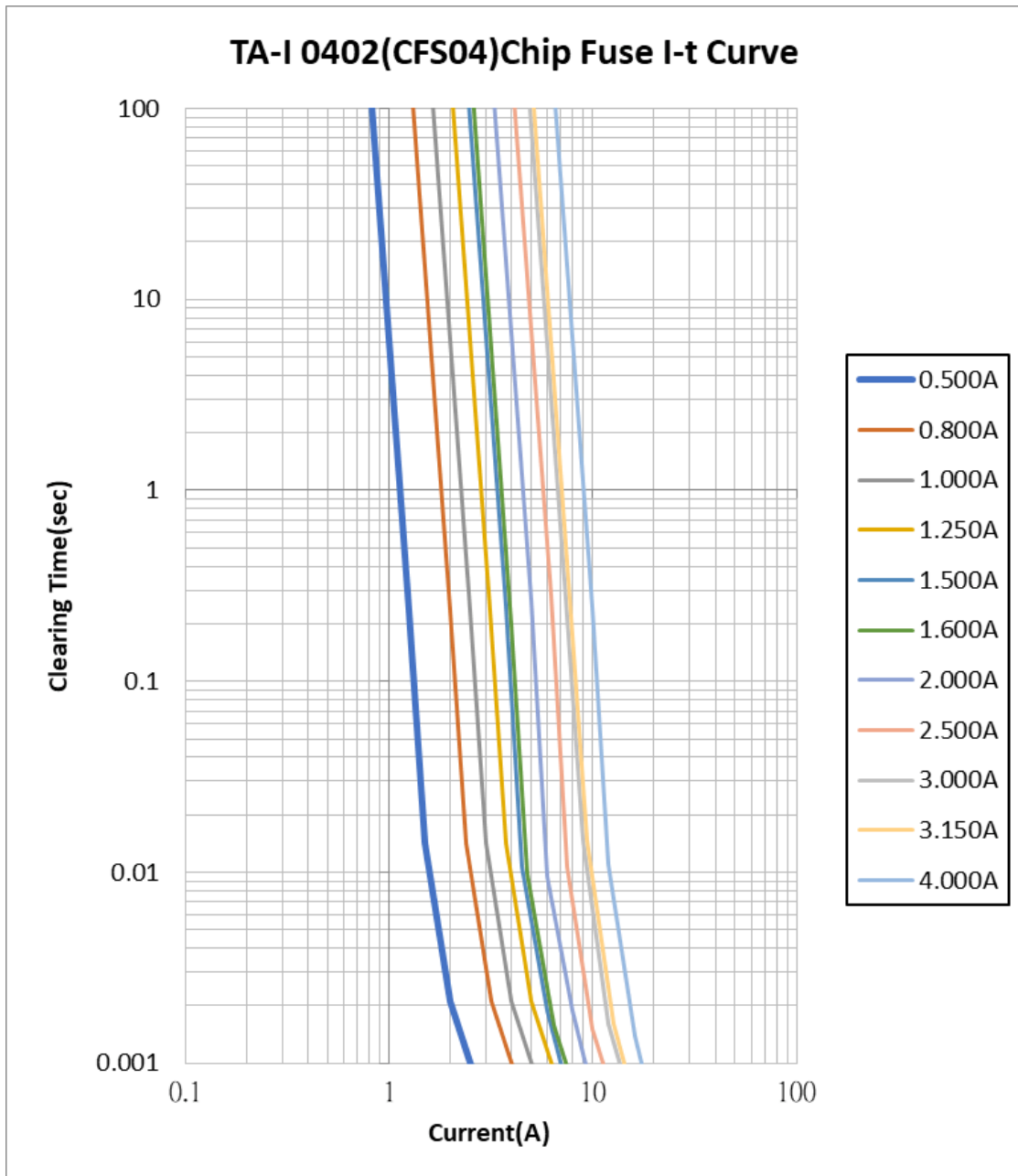
No.	Type	Waveform	Formula
1	Sinusoidal Waveform (1 Cycle)		$\frac{1}{2} I_m^2 t$
2	Sinusoidal Waveform (1/2 Cycle)		$\frac{1}{2} I_m^2 t$
3	Triangle Waveform		$\frac{1}{3} I_m^2 t$
4	Rectangular Waveform		$I_m^2 t$
5	Trapezoidal Waveform		$\frac{1}{3} I_m^2 t + I_m^2 (t_1 - t_2) + \frac{1}{3} I_m^2 (t_2 - t_3)$
6	Various Waveform 1		$I_1 I_2 t + \frac{1}{3} (I_1 - I_2)^2 t$
7	Various Waveform 2		$I_1 I_2 t + \left[I_1 I_2 t + \frac{(I_1 - I_2)^2}{3} \right] * (t_2 - t_1) + \frac{1}{3} (I_2)^2 (t_3 - t_2)$
8	Charge/Discharge Waveform		$\frac{1}{2} (I_m^2 \tau)$
9	Lightning Surge Waveform		$I_m^2 \left[\frac{t_1}{3} + 0.721 (t_2 - t_1) \right]$



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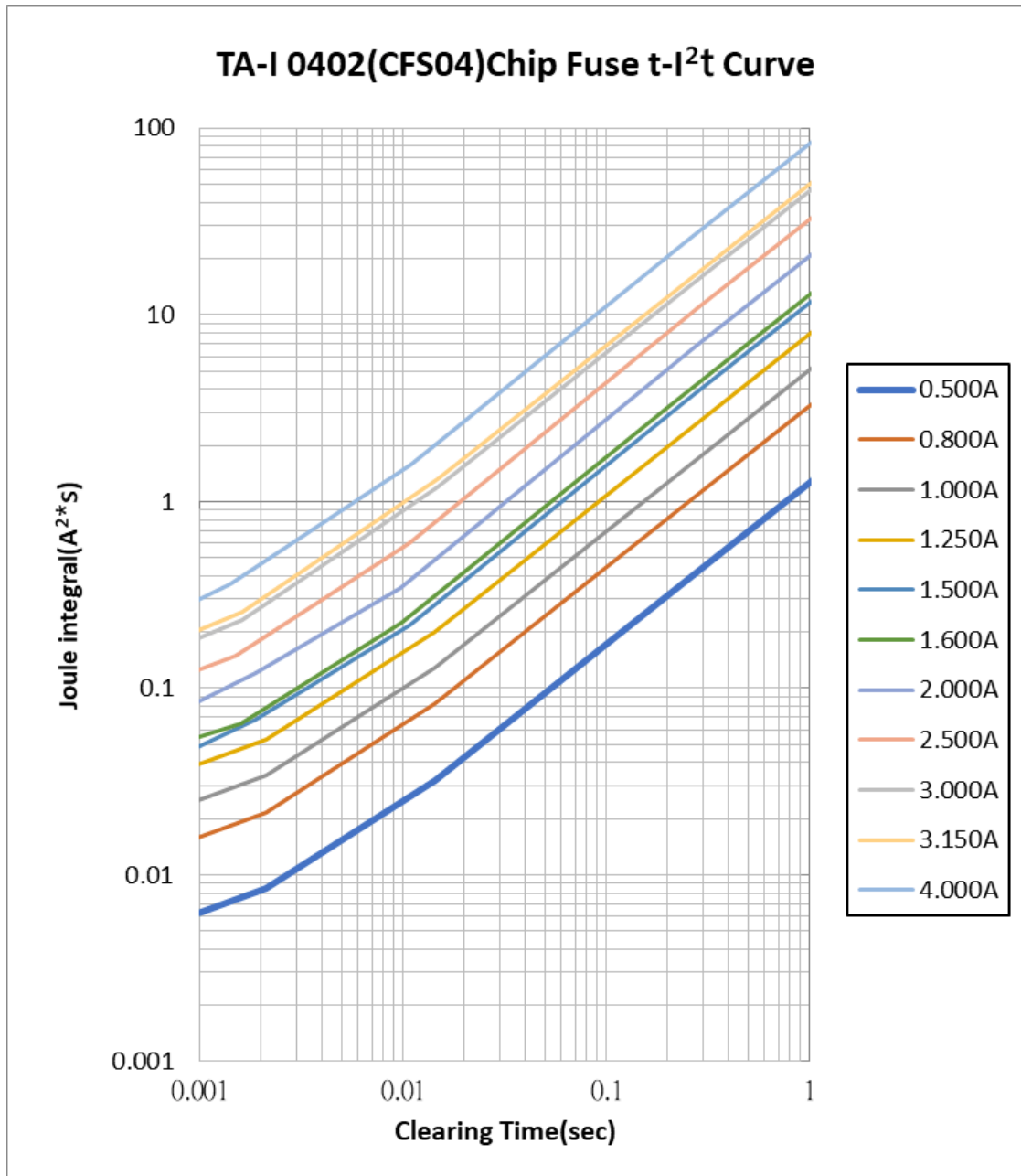




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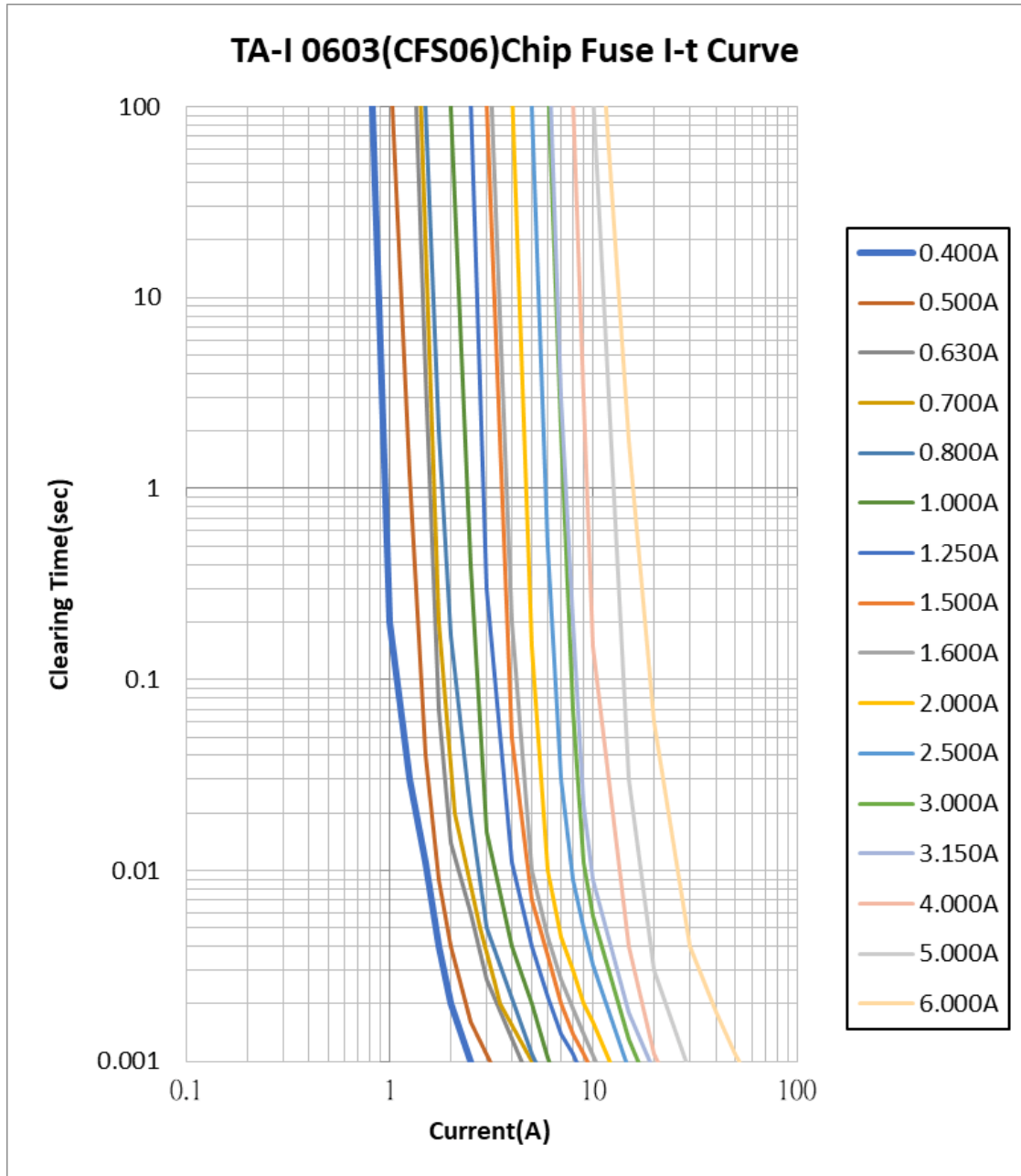




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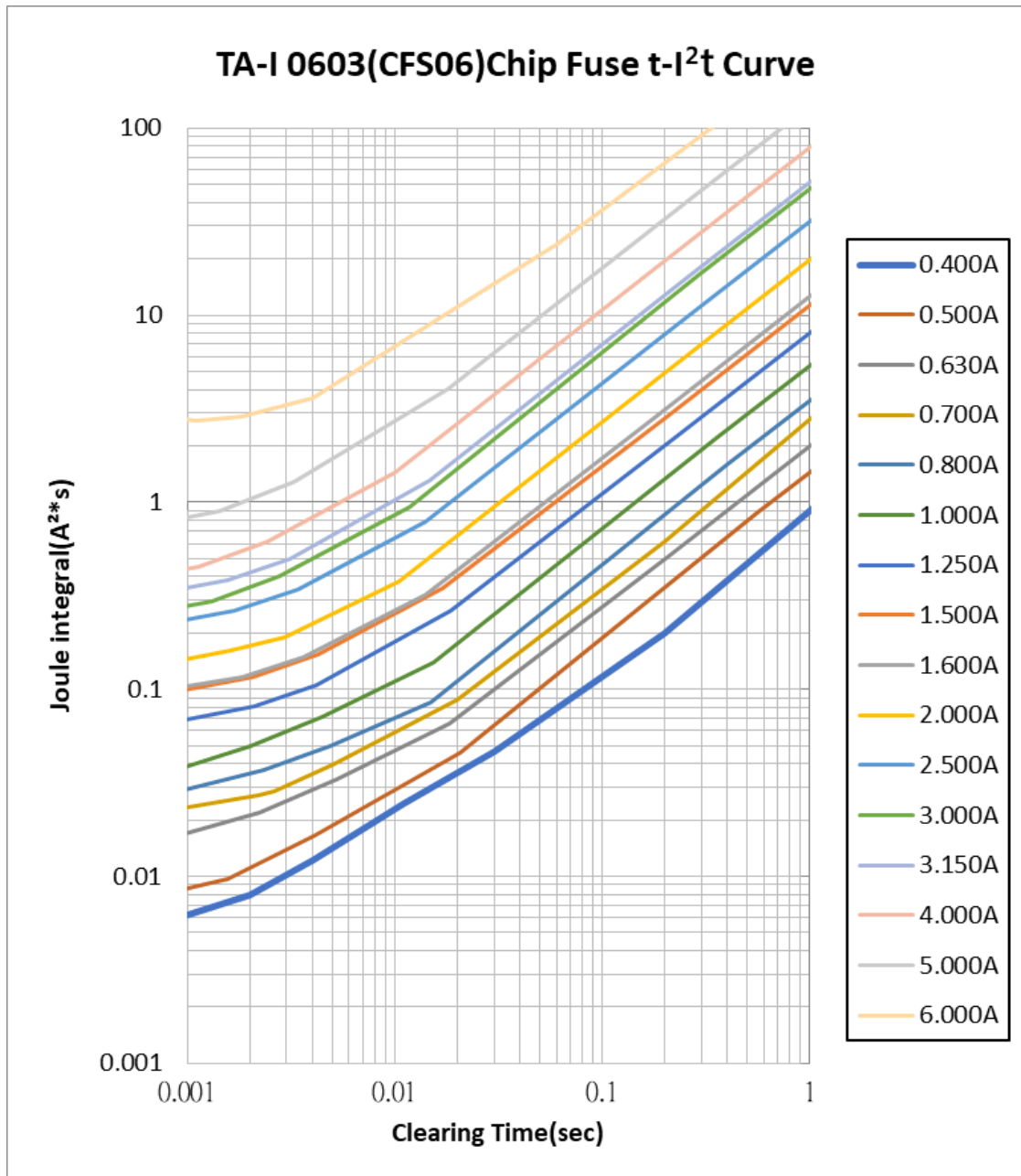




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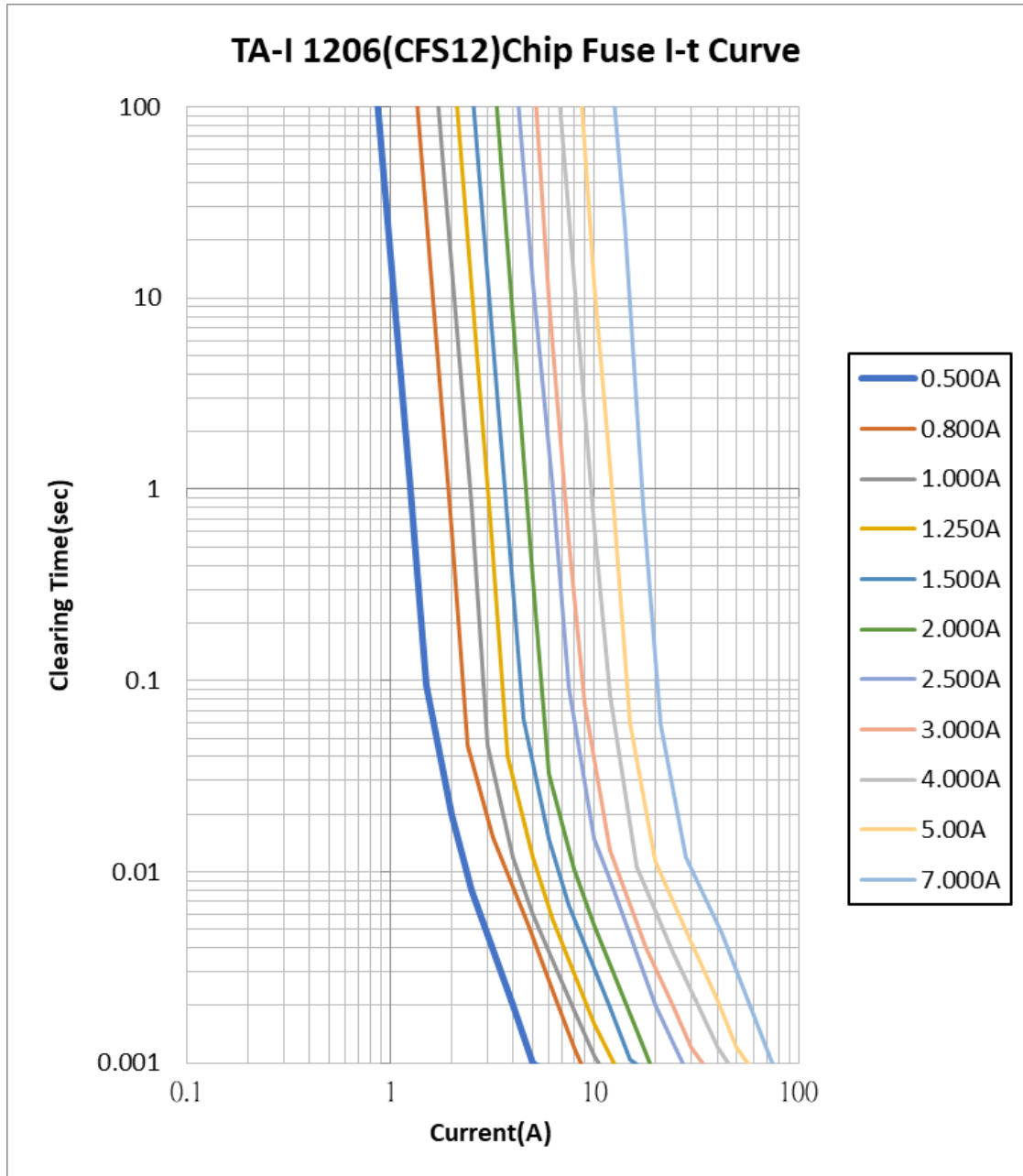




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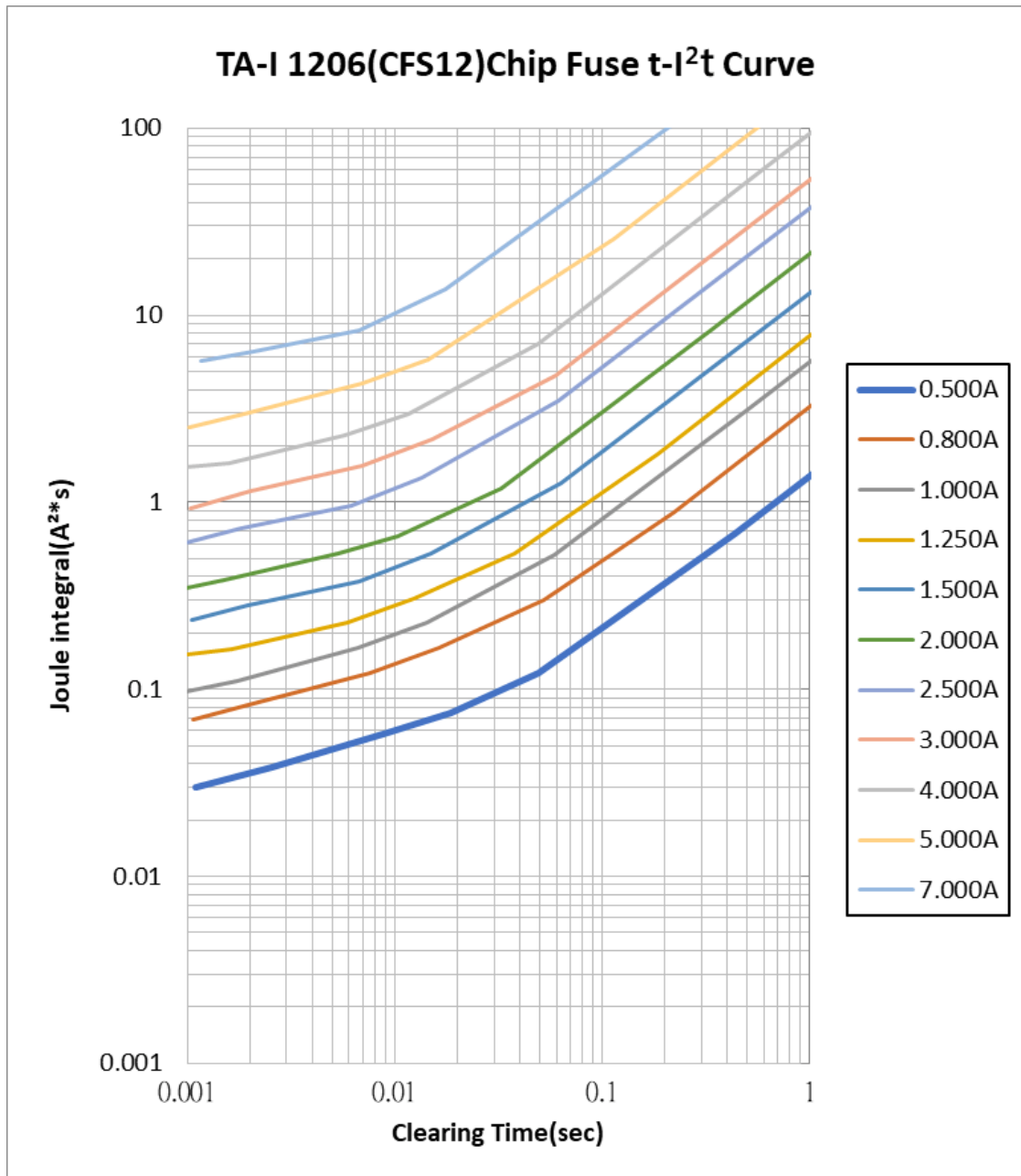




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单击下面可查看定价，库存，交付和生命周期等信息

[>>TA-I\(大毅\)](#)